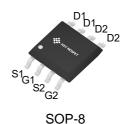


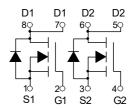
Description

The AO4832 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.



General Features

$$\begin{split} V_{DS} &= 30 V \ I_D = 11.5 A \\ R_{DS(ON)} &< 30 m \Omega \ @ \ V_{GS} = 10 \ V \\ R_{DS(ON)} &< 42 m \Omega \ @ \ V_{GS} = 4.5 V \end{split}$$



Application

Battery protection

Load switch

Uninterruptible power supply

Dual N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
AO4832	SOP-8	HXY MOSFET	3000

Absolute Maximum Ratings@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _G s	Gate-Source Voltage	<u>+</u> 20	V
I _D @T _A =25°C	Drain Current, V _{GS} @ 4.5V ³	11.5	А
I _D @T _A =70°C	Drain Current, V _{GS} @ 4.5V ³	7.8	А
Ідм	Pulsed Drain Current ¹	42	А
PD@TA=25°C	Total Power Dissipation	3.2	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rthj-a	Maximum Thermal Resistance, Junction- ambient ³	62.5	°C/W



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units	
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	30	-	-	V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V,	-	-	1.0	μΑ	
I _{GSS}	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	1.0	1.5	2.5	V	
D	Static Drain-Source on-Resistance	V _{GS} =10V, I _D =10A	-	10	13	mO ∣	
$R_{DS(on)}$	note3	V _{GS} =4.5V, I _D =5A	-	16	22.5		
C _{iss}	Input Capacitance	\\ 45\\\\\ 0\\\	-	633	-	pF	
Coss	Output Capacitance	V _{DS} =15V, V _{GS} =0V, f=1.0MHz	-	120	-	pF	
C _{rss}	Reverse Transfer Capacitance	1-1.UIVITZ	-	99	-	pF	
Qg	Total Gate Charge	\/ -45\/ -40A	-	15	-	nC	
Q _{gs}	Gate-Source Charge	V_{DS} =15V, I_{D} =10A, V_{GS} =10V	-	4.7	-	nC	
Q_{gd}	Gate-Drain("Miller") Charge	VGS-10V	-	3.6	-	nC	
t _{d(on)}	Turn-on Delay Time		-	5	-	ns	
t _r	Turn-on Rise Time	V _{DS} =30V,I _D =18A,	_	8	-	ns	
t _{d(off)}	Turn-off Delay Time	R _{GEN} =3Ω, V _{GS} =10V	_	21	-	ns	
t f	Turn-off Fall Time		-	7	-	ns	
Is	Maximum Continuous Drain to Source Current	e Diode Forward	-	-	11.5	А	
Ism	Maximum Pulsed Drain to Source Dio	de Forward Current	-	-	72	Α	
V _{SD}	Drain to Source Diode Forward	V _{GS} =0V, I _S =18A		_	1.2	V	
v 2D	Voltage	VGS-0V, IS-10/1		1.2	V		
trr	Body Diode Reverse Recovery Time		-	7	-	ns	
Qrr	Body Diode Reverse Recovery Charge	I _F =18A,dI/dt=100A/μs	-	5.9	-	nC	

Note:

^{1.} The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper. 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

^{3.} The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=20A

^{4.} The power dissipation is limited by 150 $^{\circ}$ C junction temperature

^{5.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Electrical And Thermal Characteristics

Figure1: Output Characteristics

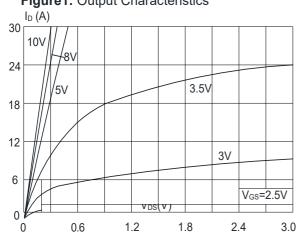


Figure 2: Typical Transfer Characteristics

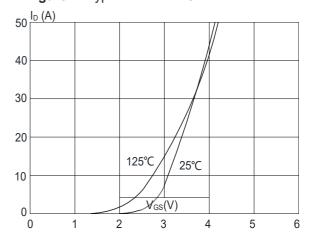


Figure 3:On-resistance vs. Drain Current RDS(ON) ($m\Omega$)

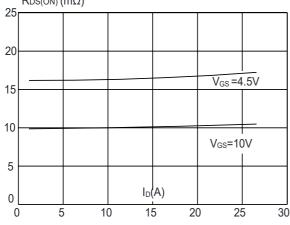


Figure 4: Body Diode Characteristics

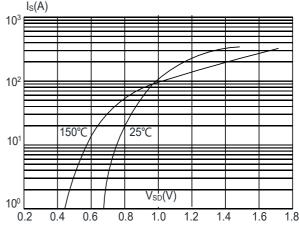


Figure 5: Gate Charge Characteristics

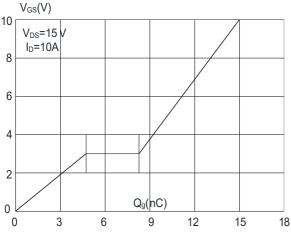


Figure 6: Capacitance Characteristics

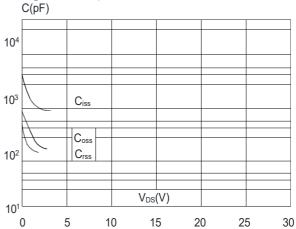




Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

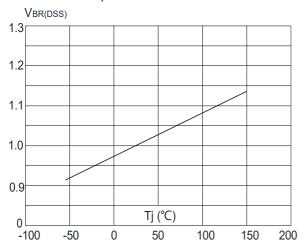


Figure 9: Maximum Safe Operating Area

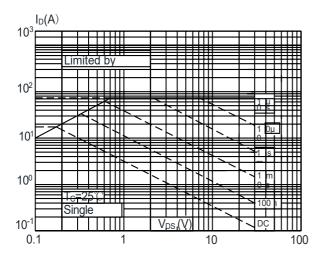


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

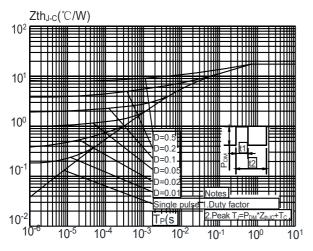


Figure 8: Normalized on Resistance vs. Junction Temperature

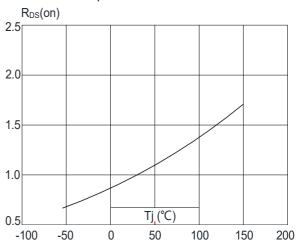
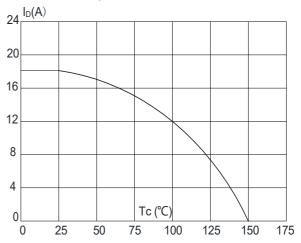
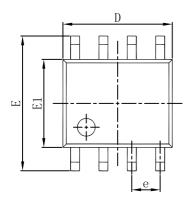


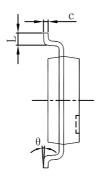
Figure 10: Maximum Continuous Drain Current vs. Case Temperature

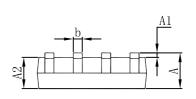




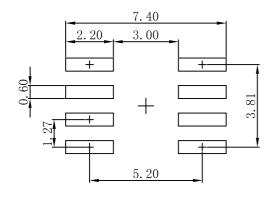
SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1. 350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0. 020	
c	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
E	5.800	6.200	0. 228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



- Note: 1.Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

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